Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10541897	LEE ET AL.	
Examiner	Art Unit	
Nguyen, Lauren	2871	

SEARCHED					
Class	Subclass	Date	Examiner		
349	61-62, 64, 67, 96, 112-113	02/06/2007	LN		

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted Primary Examiner James Reagan	02/06/2007	LN		
Consulted Supervisory Patent Examiner George Nguyen	02/07/2007	LN		

INTERFERENCE SEARCH				
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